

# DIM1600FSS12-A000

# Single Switch IGBT Module

DS5541-2.4 January 2009 (LN26557)

## **FEATURES**

- 10µs Short Circuit Withstand
- Non Punch Through Silicon
- Isolated Copper Baseplate
- Lead Free construction

#### **APPLICATIONS**

- High Power Inverters
- Motor Controllers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bidirectional switch configurations covering voltages from 1200V to 3300V and currents up to 2400A.

The DIM1600FSS12-A000 is a single switch 1200V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus full  $10\mu s$  short circuit withstand.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

#### **ORDERING INFORMATION**

### Order As:

#### DIM1600FSS12-A000

Note: When ordering, please use the whole part number.

## **KEY PARAMETERS**

V <sub>CES</sub>		1200V
V <sub>CE (sat)</sub> *	(typ)	2.2V
I <sub>c</sub>	(max)	1600A
I <sub>C(PK)</sub>	(max)	3200A

<sup>\*(</sup>measured at the power busbars and not the auxiliary terminals)

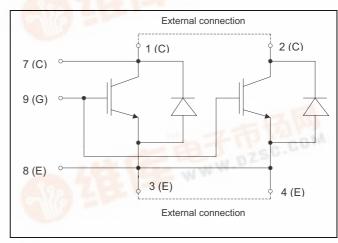


Fig. 1 Circuit configuration



Fig. 2 Module package



#### **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

#### Tcase = 25 °C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V$	1200	٧
V <sub>GES</sub>	Gate-emitter voltage		±20	٧
Ic	Continuous collector current	T <sub>case</sub> = 85 ℃	1600	Α
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> =115 ℃	3200	Α
P <sub>max</sub>	Max. transistor power dissipation	T <sub>case</sub> = 25 °C, T <sub>j</sub> = 150 °C	13890	W
l <sup>2</sup> t	Diode I <sup>2</sup> t value (IGBT arm)	$V_R = 0, t_P = 10 \text{ms}, T_{vj} = 125 ^{\circ}\text{C}$	400	kA <sup>2</sup> S
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V



## THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
R <sub>th(j-c)</sub>	Thermal resistance - transistor	Continuous dissipation – junction to case	ı	-	9	°C/kW
$R_{th(j-c)}$	Thermal resistance - diode	Continuous dissipation – junction to case	-	-	20	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	8	°C/kW
Tj	Junction temperature	Transistor	-	-	150	∞
		Diode	-	-	125	℃
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	∞
-	Screw torque	Mounting – M6	-	-	5	Nm
	·	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm



## **ELECTRICAL CHARACTERISTICS**

## $T_{case} = 25$ °C unless stated otherwise.

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
I <sub>ces</sub>	Collector cut-off current	V <sub>GE</sub> = OV, V <sub>CE</sub> = V <sub>CES</sub>		-	-	2.0	mA
		V <sub>GE</sub> = OV, V <sub>CE</sub> = V <sub>CES</sub> , T <sub>case</sub> = 125 °C	С	-	-	50	mA
I <sub>ces</sub>	Gate leakage current	$V_{GE} = \pm 20V$ , $V_{CE} = 0V$		-	-	8	μΑ
$V_{\text{GE(TH)}}$	Gate threshold voltage	$I_C = 80 \text{mA}, V_{GE} = V_{CE}$		4.5	5.5	6.5	V
$V_{CE(sat)^{\dagger}}$	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 1600A		-	2.2	2.8	V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 1600A, T <sub>case</sub> = 125°	∞	-	2.6	3.3	V
I <sub>F</sub>	Diode forward current	DC		-	-	1600	Α
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms		-	-	3200	Α
$V_{F^\dagger}$	Diode forward voltage	I <sub>F</sub> = 1600A		-	2.1	2.4	V
		I <sub>F</sub> = 1600A, T <sub>case</sub> = 125 °C		-	2.1	2.4	V
Cies	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		-	180	-	nF
$L_M$	Module inductance	-		-	15	-	nH
R <sub>INT</sub>	Internal transistor resistance	-		-	0.27	-	mΩ
SC <sub>Data</sub>	Short circuit. I <sub>sc</sub>	$T_j = 125 ^{\circ}\text{C}, V_{cc} = 900 ^{\circ}\text{V},$	I <sub>1</sub>	-	11000	-	Α
		$\begin{array}{l} t_p \leq 10 \mu s, \ V_{ge} \leq \! 15 V \\ V_{CE(max)} = V_{CES} - L.^* \times \! di/dt \\ IEC \ 60747-9 \end{array}$	l <sub>2</sub>	-	9000	-	А

#### Note:

 $_{\frac{t}{}}$  Measured at the power busbars and not the auxiliary terminals

 $<sup>^{*}</sup>$  L is the circuit inductance + L<sub>M</sub>



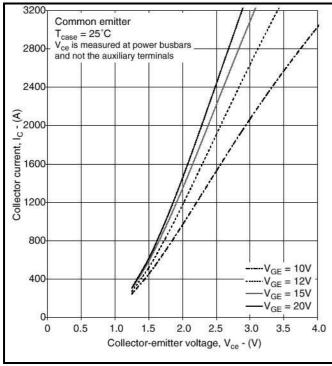
## **ELECTRICAL CHARACTERISTICS**

## $T_{case}$ = 25 °C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$t_{d(off)}$	Turn-off delay time	I <sub>C</sub> = 1600A	-	1250	-	ns
t <sub>f</sub>	Fall time	V <sub>GE</sub> = ±15V	-	180	-	ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 600V	-	300	-	mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 1.5\Omega$	-	250	-	ns
t <sub>r</sub>	Rise time	L ~ 100nH	-	200	-	ns
E <sub>ON</sub>	Turn-on energy loss		-	80	-	mJ
$Q_g$	Gate charge		-	18	-	μC
Q <sub>rr</sub>	Diode reverse recovery charge	$I_F = 1600A, V_R = 600V,$	-	150	-	μС
I <sub>rr</sub>	Diode reverse current	dl <sub>F</sub> /dt =8200A/μs	-	750	-	Α
E <sub>REC</sub>	Diode reverse recovery energy		-	90	-	mJ

## T<sub>case</sub> = 125 ℃ unless stated otherwise.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$t_{d(off)}$	Turn-off delay time	I <sub>C</sub> = 1600A	-	1500	-	ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$	-	200	-	ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 600V	-	350	-	mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 1.5\Omega$	-	350	-	ns
t <sub>r</sub>	Rise time	L ∼ 60nH	-	220	-	ns
E <sub>ON</sub>	Turn-on energy loss		-	150	-	mJ
Q <sub>rr</sub>	Diode reverse recovery charge	$I_F = 1600A, V_R = 600V,$	-	350	-	μC
I <sub>rr</sub>	Diode reverse current	$dI_F/dt = 7500A/\mu s$	-	900	-	Α
E <sub>REC</sub>	Diode reverse recovery energy		-	160	-	mJ



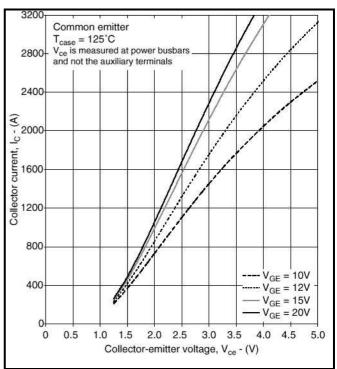


Fig.3 Typical output characteristics

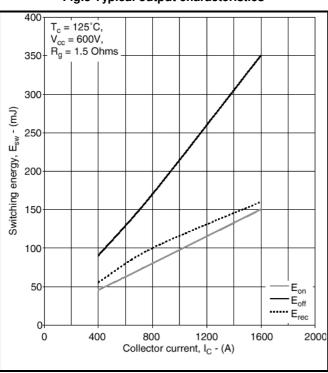


Fig.5 Typical switching energy vs collector current

Fig.4 Typical output characteristics

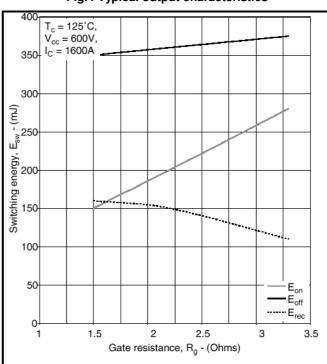
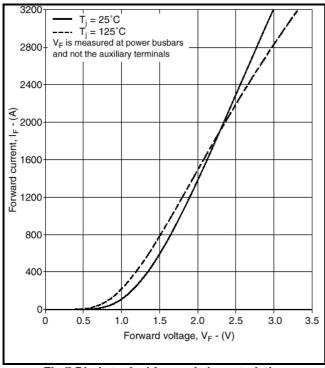


Fig.6 Typical switching energy vs gate resistance



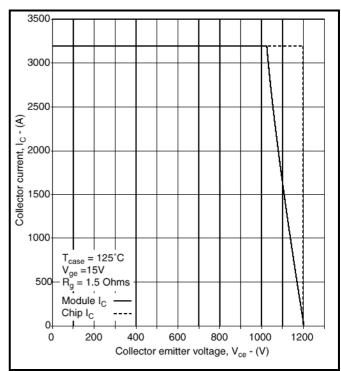


Fig.7 Diode typical forward characteristics

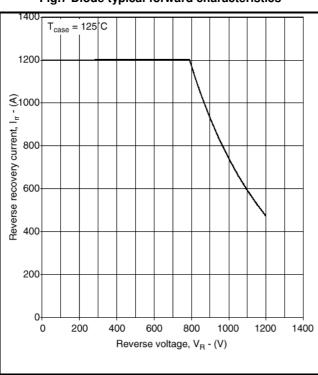


Fig.9 Diode reverse bias safe operating area

Fig.8 Reverse bias safe operating area

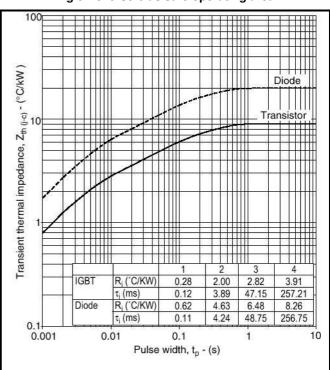


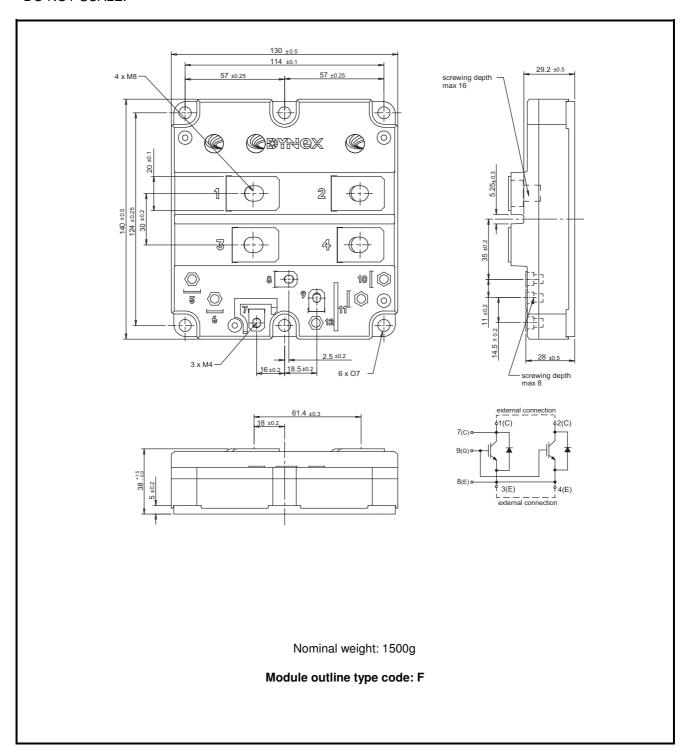
Fig.10 Transient thermal impedance



#### **PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.





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